Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/724,729	UMEHARA ET AL.	
Examiner	Art Unit	
Shih-Chao Chen	2821	

SEARCHED				
Class	Subclass	Date	Examiner	
343	700MS, 702, 725, 815, 817, 846	7/11/2005	CHEN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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EAST (See attached printout).	7/11/2005	CHEN
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